Power MOSFET 75 Amps, 30 Volts

N-Channel TO-220 and D²PAK

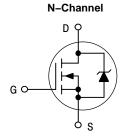
This 20 V_{GS} gate drive vertical Power MOSFET is a general purpose part that provides the "best of design" available today in a low cost power package. This power MOSFET is designed to withstand high energy in the avalanche and commutation modes. The Drain–to–Source Diode has a fast response with soft recovery.

Features

- Ultra-Low R_{DS(on)}, Single Base, Advanced Technology
- SPICE Parameters Available
- Diode is Characterized for Use in Bridge Circuits
- I_{DSS} and V_{DS(on)} Specified at Elevated Temperatures
- High Avalanche Energy Capability
- ESD JEDAC Rated HBM Class 1, MM Class B, CDM Class 0
- Pb-Free Packages are Available

Typical Applications

- Power Supplies
- Inductive Loads
- PWM Motor Controls
- Replaces MTP1306 and MTB1306

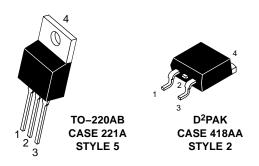




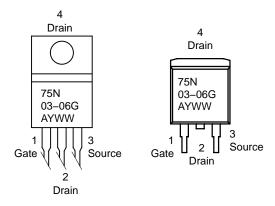
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
30 V	$5.3~\mathrm{m}\Omega$ @ $10~\mathrm{V}$	75 A



MARKING DIAGRAMS & PIN ASSIGNMENTS



 N75N03-06
 = Device Code

 A
 = Assembly Location

 Y
 = Year

 WW
 = Work Week

 G
 = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	30	Vdc
Drain-to-Gate Voltage (RGS = 10 MΩ)	V_{DGB}	30	Vdc
Gate-to-Source Voltage - Continuous	V _{GS}	±20	Vdc
Non-repetitive (tp ≤ 10 ms)	V _{GS}	±24	Vdc
Drain Current - Continuous @ $T_C = 25^{\circ}C$ - Continuous @ $T_C = 100^{\circ}C$ - Single Pulse (tp \leq 10 μ s)	I _D I _D I _{DM}	75 59 225	Adc Apk
Total Power Dissipation @ T _C = 25°C Derate above 25°C Total Power Dissipation @ T _A = 25°C (Note 1)	P _D	125 1.0 2.5	W W/°C W
Operating and Storage Temperature Range	T _J and T _{stg}	-55 to 150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting T_J = 25°C (V_{DD} = 38 Vdc, V_{GS} = 10 Vdc, L = 1 mH, I_L (pk) = 55 A, V_{DS} = 40 Vdc)	E _{AS}	1500	mJ
Thermal Resistance - Junction-to-Case - Junction-to-Ambient - Junction-to-Ambient (Note 1)	R _{θJC} R _{θJA} R _{θJA}	1.0 62.5 50	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8 in from case for 10 seconds	TL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. When surface mounted to an FR4 board using the minimum recommended pad size.

ORDERING INFORMATION

Device	Package	Shipping [†]
NTP75N03-06	TO-220	50 Units / Rail
NTP75N03-06G	TO-220 (Pb-Free)	50 Units / Rail
NTB75N03-06	D ² PAK	50 Units / Rail
NTB75N03-06G	D ² PAK (Pb-Free)	50 Units / Rail
NTB75N03-06T4	D ² PAK	800 Units / Tape & Reel
NTB75N03-06T4G	D ² PAK (Pb-Free)	800 Units / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

1	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS					_	
Drain – Source Breakdown Voltov ($V_{GS} = 0$ Vdc, $I_D = 250 \mu Adc$) Temperature Coefficient (Nega	V _{(BR)DSS}	30	_ _57	- -	Vdc mV°C	
Zero Gate Voltage Drain Curre ($V_{DS} = 30 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$) ($V_{DS} = 30 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$)		I _{DSS}	- -	- -	1.0 10	μAdc
Gate-Body Leakage Current	$(V_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	I _{GSS}	_	-	±100	nAdc
ON CHARACTERISTICS (Not	e 2)					
Gate Threshold Voltage (Note $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coeffic	,	V _{GS(th)}	1.0	1.6 -6	2.0	Vdc mV°C
Static Drain-to-Source On-Re (V _{GS} = 10 Vdc, I _D = 37.5 Adc)	esistance (Note 2)	R _{DS(on)}	_	5.3	6.5	mΩ
Static Drain-to-Source On Re $(V_{GS} = 10 \text{ Vdc}, I_D = 75 \text{ Adc})$ $(V_{GS} = 10 \text{ Vdc}, I_D = 37.5 \text{ Adc},$	V _{DS(on)}	- -	0.53 0.35	0.68 0.50	Vdc	
Forward Transconductance (N	otes 2 & 4) (V _{DS} = 3 Vdc, I _D = 20 Adc)	9FS	_	58	-	Mhos
DYNAMIC CHARACTERISTIC	S (Note 4)					
Input Capacitance		C _{iss}	_	4398	5635	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0, \\ f = 1.0 \text{ MHz})$	C _{oss}	_	1160	1894	
Transfer Capacitance	,	C_{rss}	_	317	430	
SWITCHING CHARACTERIST	FICS (Notes 3 and 4)					
Turn-On Delay Time		t _{d(on)}	_	16	30	ns
Rise Time	$(V_{GS} = 5.0 \text{ Vdc}, V_{DD} = 20 \text{ Vdc}, I_{D} = 75 \text{ Adc},$	t _r	_	130	200	
Turn-Off Delay Time	$R_G = 4.7 \Omega$) (Note 2)	$t_{d(off)}$	_	65	110	
Fall Time		t _f	-	105	175	
Gate Charge	(V _{GS} = 5.0 Vdc,	Q_{T}	-	57	75	nC
	I _D = 75 Adc, V _{DS} = 24 Vdc) (Note 2)	Q ₁	_	11	15	
	V _{DS} = 24 VdC) (Note 2)	Q_2	_	34	50	
SOURCE-DRAIN DIODE CHA	ARACTERISTICS					
Forward On-Voltage	$(I_S = 75 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 75 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$ (Note 2)	V_{SD}	-	1.19 1.09	1.25 -	Vdc
Reverse Recovery Time	(I _S = 75 Adc, V _{GS} = 0 Vdc	t _{rr}	_	37	-	ns
(Note 4)		ta	_	20	_	
Reverse Recovery Stored	dl _S /dt = 100 A/μs) (Note 2)	t _b	_	17	_	μС
Charge (Note 4)		Q _{RR}	-	0.023	_]

- Pulse Test: Pulse Width ≤ 300 μS, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.
 From characterization test data.

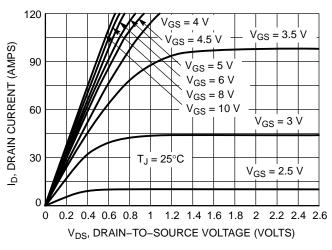


Figure 1. On-Region Characteristics

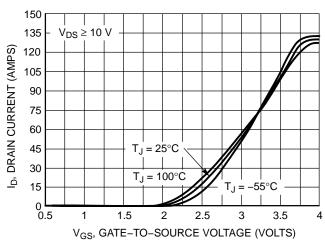


Figure 2. Transfer Characteristics

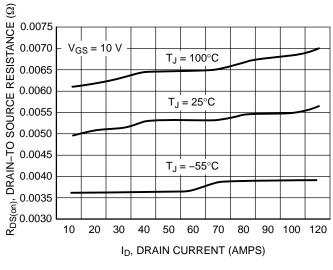


Figure 3. On-Resistance vs. Drain Current and **Temperature**

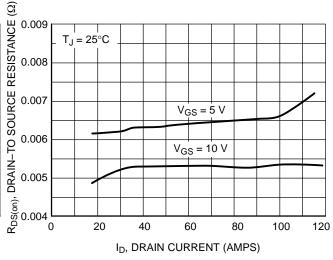


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

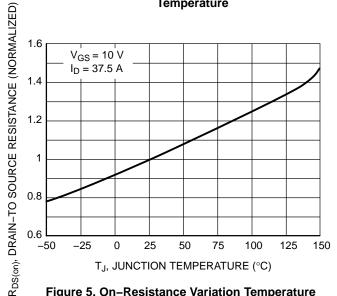


Figure 5. On-Resistance Variation Temperature

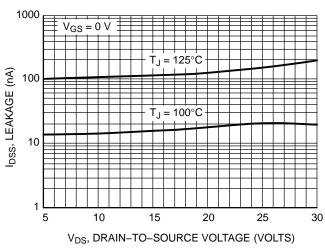


Figure 6. Drain-to-Source Leakage Current vs. Voltage

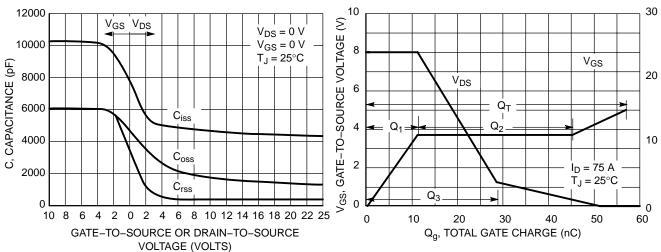


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

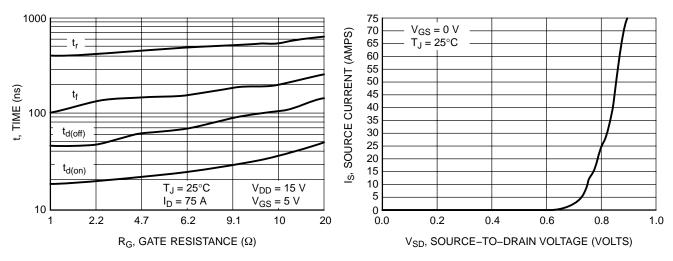


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

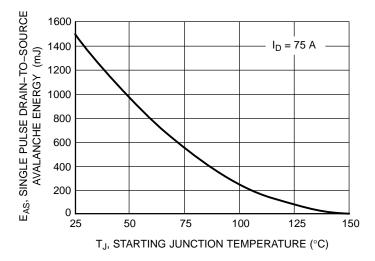
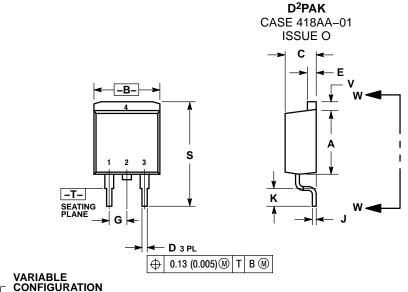


Figure 11. Maximum Avalanche Energy vs. Starting Junction Temperature

PACKAGE DIMENSIONS

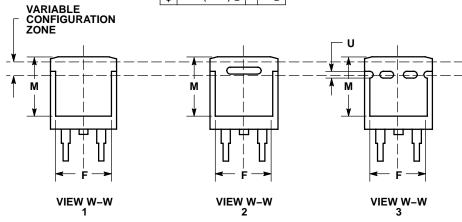


NOTES:

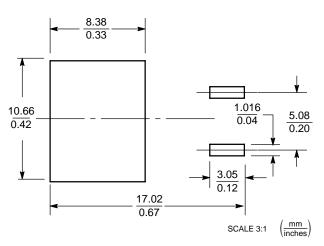
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.036	0.51	0.92
E	0.045	0.055	1.14	1.40
F	0.310		7.87	
G	0.100 BSC		2.54	BSC
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
M	0.280		7.11	
S	0.575	0.625	14.60	15.88
V	0.045	0.055	1.14	1.40

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN



SOLDERING FOOTPRINT*

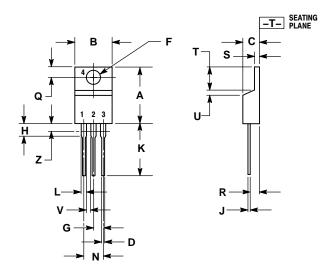


^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

TO-220 THREE-LEAD TO-220AB

CASE 221A-09 ISSUE AA



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI
 Y14 5M 1982
- Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 5:

- PIN 1. GATE 2. DRAIN
 - 3. SOURCE
 - 4. DRAIN

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